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APPLICANTS  
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\*\* FOREIGN APPLICATIONS .....  
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35 USC 119 (a-d) conditions met <input checked="" type="checkbox"/> yes <input type="checkbox"/> no <input type="checkbox"/> Met after allowance				
Verified and Acknowledged	Examiner's Signature <i>[Signature]</i>	Initials <i>[Initials]</i>		

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TITLE  
 Substrate testing device and substrate testing method

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